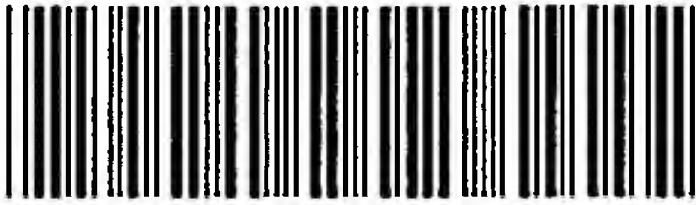


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/604,344	CHEN ET AL.	
	Examiner	Art Unit	
	Long K. Tran	2818	

SEARCHED			
Class	Subclass	Date	Examiner
257	301,304	2/11/2005	LKT
257	313,532	2/11/2005	LKT
257	302,305	2/16/2005	LKT
438	242,242	2/16/2005	LKT
438	386	2/16/2005	LKT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	301,304	2/11/2005	LKT
257	302,305	2/16/2005	LKT
438	242,243	2/16/2005	LKT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST searched	2/11/2005	LKT
EAST searched	2/16/2005	LKT